

## PRODUCT FEATURES

- IGBT CHIP(Trench+Field Stop technology)
- $V_{CE(sat)}$  with positive temperature coefficient
- High short circuit capability
- Fast switching and short tail current
- Free wheeling diodes with fast and soft reverse recovery
- Low switching losses

## APPLICATIONS

- High frequency switching application
- Medical applications
- Motion/servo control
- UPS systems



### IGBT-inverter

ABSOLUTE MAXIMUM RATINGS( $T_C=25^\circ\text{C}$  unless otherwise specified)

Symbol	Parameter/Test Conditions		Values	Unit
$V_{CES}$	Collector Emitter Voltage	$T_J=25^\circ\text{C}$	1200	V
$V_{GES}$	Gate Emitter Voltage		$\pm 20$	
$I_C$	DC Collector Current	$T_C=25^\circ\text{C}, T_{Jmax}=175^\circ\text{C}$	300	A
		$T_C=100^\circ\text{C}, T_{Jmax}=175^\circ\text{C}$	200	
$I_{CM}$	Repetitive Peak Collector Current	$tp=1\text{ms}$	400	
$P_{tot}$	Power Dissipation Per IGBT	$T_C=25^\circ\text{C}, T_{Jmax}=175^\circ\text{C}$	1071	W

### Diode-inverter

ABSOLUTE MAXIMUM RATINGS ( $T_C=25^\circ\text{C}$  unless otherwise specified)

Symbol	Parameter/Test Conditions		Values	Unit
$V_{RRM}$	Repetitive Reverse Voltage	$T_J=25^\circ\text{C}$	1200	V
$I_{F(AV)}$	Average Forward Current		200	A
$I_{FRM}$	Repetitive Peak Forward Current	$tp=1\text{ms}$	400	
$I^2t$		$T_J=125^\circ\text{C}, t=10\text{ms}, V_R=0\text{V}$	11.25	$\text{KA}^2\text{S}$

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# MMG200D120B6TC

## IGBT-inverter

### ELECTRICAL CHARACTERISTICS ( $T_C=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions		Min.	Typ.	Max.	Unit	
$V_{GE(th)}$	Gate Emitter Threshold Voltage	$V_{CE}=V_{GE}, I_C=8\text{mA}$	5.0	5.8	6.5	V	
$V_{CE(sat)}$	Collector - Emitter Saturation Voltage	$I_C=200\text{A}, V_{GE}=15\text{V}, T_J=25^\circ\text{C}$		1.8	2.25		
		$I_C=200\text{A}, V_{GE}=15\text{V}, T_J=125^\circ\text{C}$		2.1			
		$I_C=200\text{A}, V_{GE}=15\text{V}, T_J=150^\circ\text{C}$		2.15			
$I_{CES}$	Collector Leakage Current	$V_{CE}=1200\text{V}, V_{GE}=0\text{V}, T_J=25^\circ\text{C}$			1	mA	
		$V_{CE}=1200\text{V}, V_{GE}=0\text{V}, T_J=150^\circ\text{C}$			10		
$I_{GES}$	Gate Leakage Current	$V_{CE}=0\text{V}, V_{GE}=\pm 20\text{V}, T_J=25^\circ\text{C}$	-400		400	nA	
$R_{gint}$	Integrated Gate Resistor			3.5		$\Omega$	
$Q_g$	Gate Charge	$V_{CE}=600\text{V}, I_C=200\text{A}, V_{GE}=15\text{V}$		1.06		$\mu\text{C}$	
$C_{ies}$	Input Capacitance	$V_{CE}=25\text{V}, V_{GE}=0\text{V}, f=1\text{MHz}$		14.2		nF	
$C_{res}$	Reverse Transfer Capacitance				600		pF
$t_{d(on)}$	Turn on Delay Time	$V_{CC}=600\text{V}, I_C=200\text{A}$ $R_G=2.7\Omega,$ $V_{GE}=\pm 15\text{V},$ Inductive Load	$T_J=25^\circ\text{C}$		160	ns	
			$T_J=125^\circ\text{C}$		180	ns	
			$T_J=150^\circ\text{C}$		190	ns	
$t_r$	Rise Time		$T_J=25^\circ\text{C}$		56	ns	
			$T_J=125^\circ\text{C}$		60	ns	
			$T_J=150^\circ\text{C}$		60	ns	
$t_{d(off)}$	Turn off Delay Time	$T_J=25^\circ\text{C}$		380	ns		
		$T_J=125^\circ\text{C}$		430	ns		
		$T_J=150^\circ\text{C}$		450	ns		
$t_f$	Fall Time	$T_J=25^\circ\text{C}$		100	ns		
		$T_J=125^\circ\text{C}$		180	ns		
		$T_J=150^\circ\text{C}$		200	ns		
$E_{on}$	Turn on Energy	$V_{CC}=600\text{V}, I_C=200\text{A}$ $R_G=2.7\Omega,$ $V_{GE}=\pm 15\text{V},$ Inductive Load	$T_J=125^\circ\text{C}$		30	mJ	
			$T_J=150^\circ\text{C}$		33	mJ	
$E_{off}$	Turn off Energy		$T_J=125^\circ\text{C}$		16.4	mJ	
			$T_J=150^\circ\text{C}$		18.4	mJ	
$I_{SC}$	Short Circuit Current		$tp_{sc} \leq 10\mu\text{S}, V_{GE}=15\text{V}$ $T_J=125^\circ\text{C}, V_{CC}=800\text{V}$		840		A
$R_{thJC}$	Junction to Case Thermal Resistance (Per IGBT)				0.14	K/W	

## Diode-inverter

### ELECTRICAL CHARACTERISTICS ( $T_C=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions		Min.	Typ.	Max.	Unit
$V_F$	Forward Voltage	$I_F=200\text{A}, V_{GE}=0\text{V}, T_J=25^\circ\text{C}$		1.75	2.3	V
		$I_F=200\text{A}, V_{GE}=0\text{V}, T_J=125^\circ\text{C}$		1.5		
		$I_F=200\text{A}, V_{GE}=0\text{V}, T_J=150^\circ\text{C}$		1.45		
$t_{rr}$	Reverse Recovery Time	$I_F=200\text{A}, V_R=600\text{V}$ $dI_F/dt=-3100\text{A}/\mu\text{s}$ $T_J=150^\circ\text{C}$		580		ns
$I_{RRM}$	Max. Reverse Recovery Current			200		A
$Q_{RR}$	Reverse Recovery Charge			47.5		$\mu\text{C}$
$E_{rec}$	Reverse Recovery Energy			16.3		mJ
$R_{thJCD}$	Junction to Case Thermal Resistance (Per Diode)				0.2	K/W

# MMG200D120B6TC

## MODULE CHARACTERISTICS ( $T_C=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions	Values	Unit	
$T_{Jmax}$	Max. Junction Temperature	175	$^\circ\text{C}$	
$T_{Jop}$	Operating Temperature	-40~150		
$T_{stg}$	Storage Temperature	-40~125		
$V_{isol}$	Isolation Breakdown Voltage	AC, 50Hz(R.M.S), t=1minute	3000	V
CTI	Comparative Tracking Index		> 225	
Torque	to heatsink	Recommended (M6)	3~5	Nm
	to terminal	Recommended (M6)	2.5~5	Nm
Weight			300	g

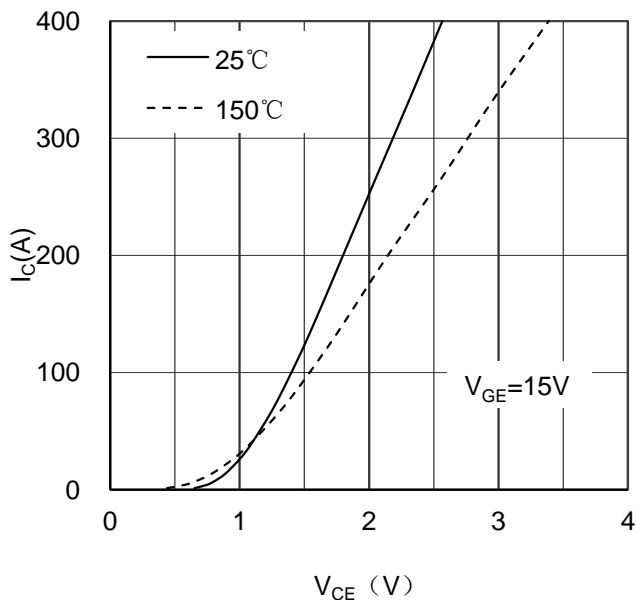


Figure 1. Typical Output Characteristics IGBT-inverter

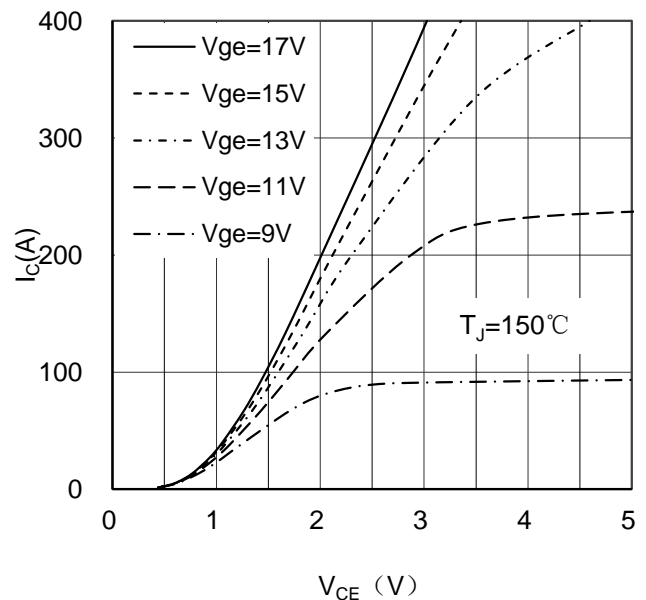


Figure 2. Typical Output Characteristics IGBT-inverter

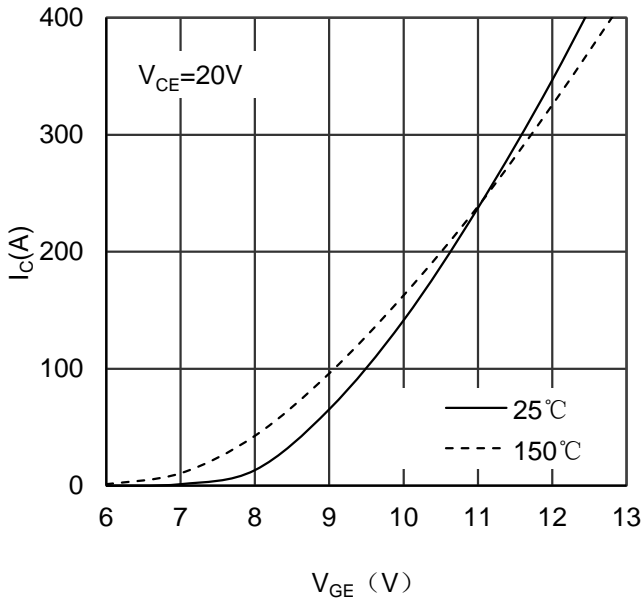


Figure 3. Typical Transfer characteristics IGBT-inverter

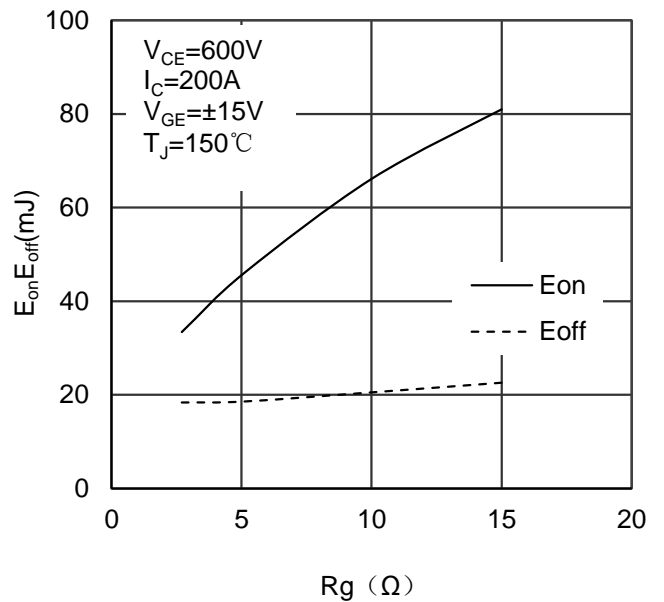


Figure 4. Switching Energy vs Gate Resistor IGBT-inverter

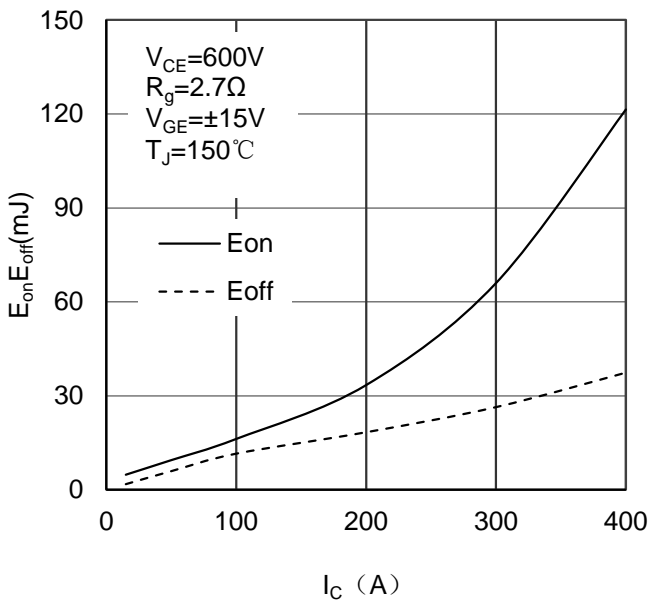


Figure 5. Switching Energy vs Collector Current IGBT-inverter

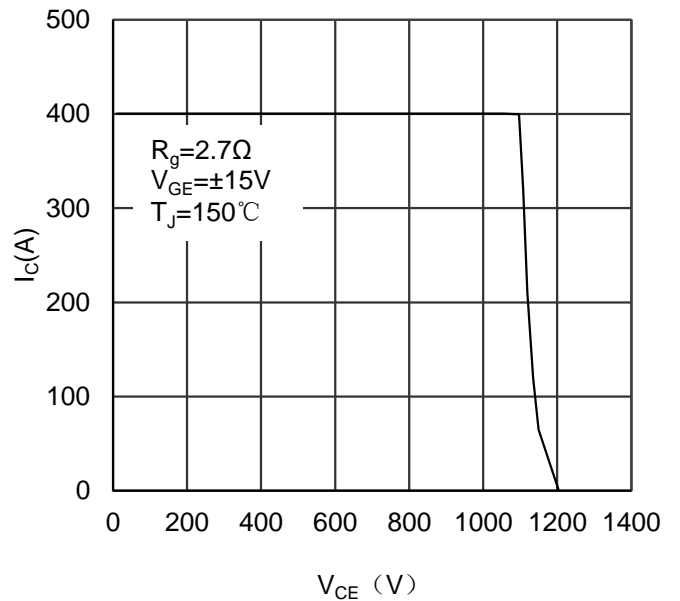


Figure 6. Reverse Biased Safe Operating Area IGBT-inverter

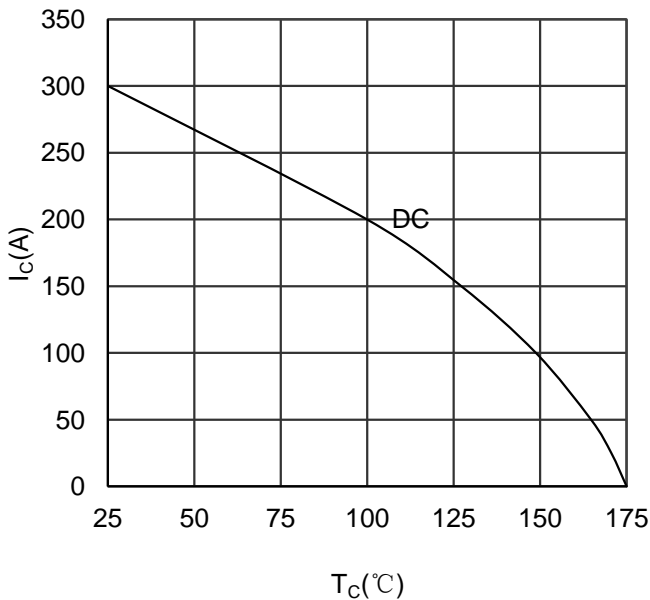


Figure 7. Collector Current vs Case temperature IGBT-inverter

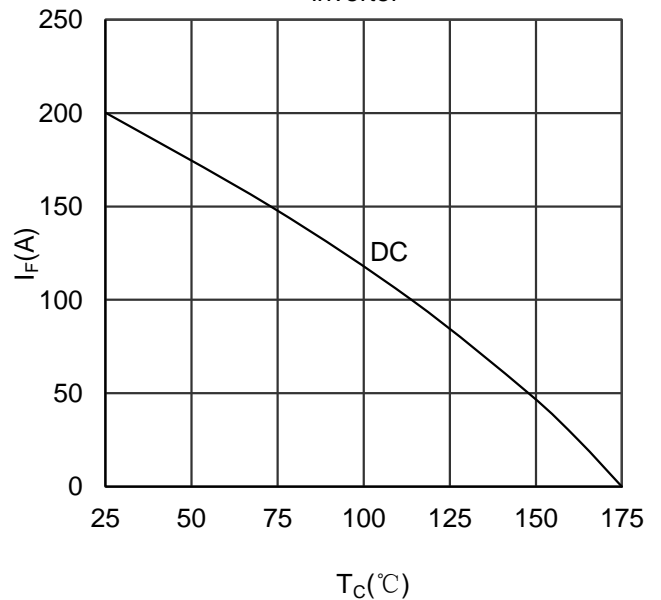


Figure 8. Forward current vs Case temperature Diode-inverter

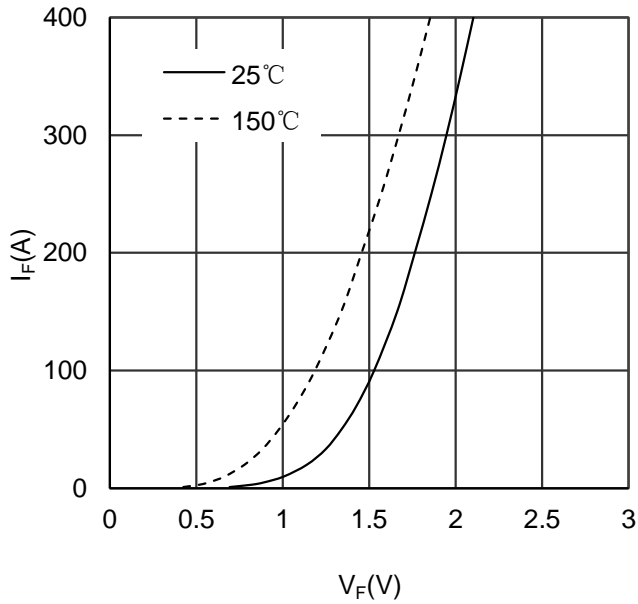


Figure 9. Diode Forward Characteristics Diode -inverter

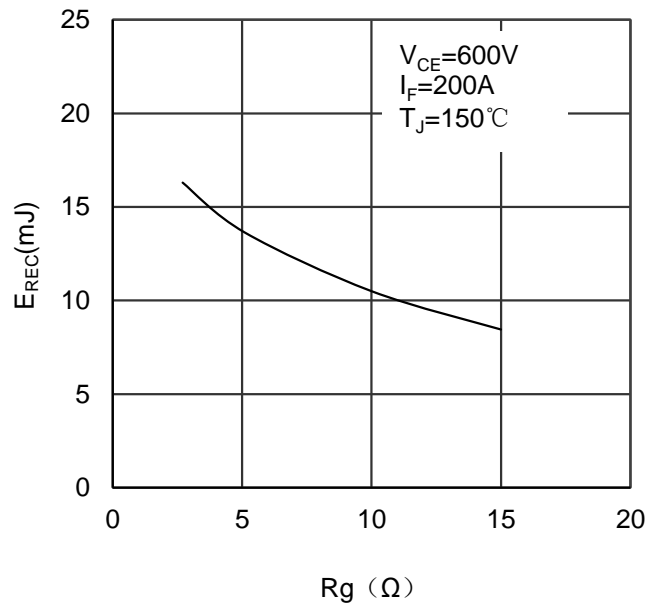


Figure 10. Switching Energy vs Gate Resistor Diode - inverter

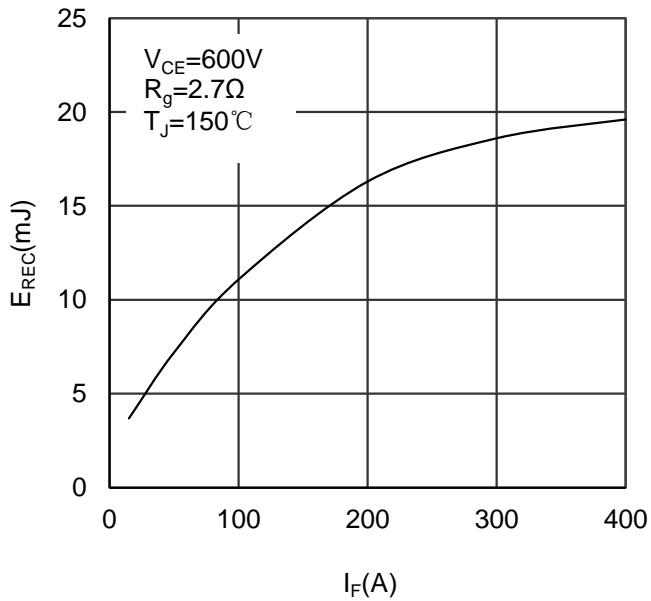


Figure 11. Switching Energy vs Forward Current Diode-inverter

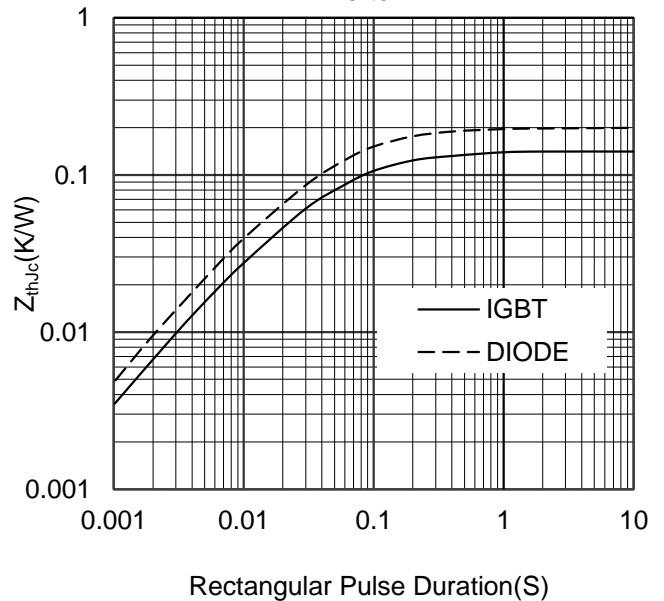


Figure 12. Transient Thermal Impedance of Diode and IGBT-inverter

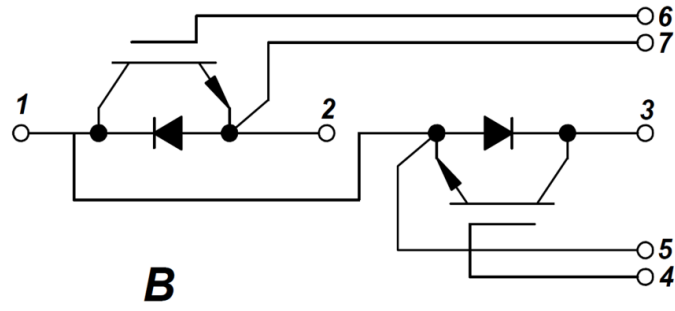


Figure 13. Circuit Diagram

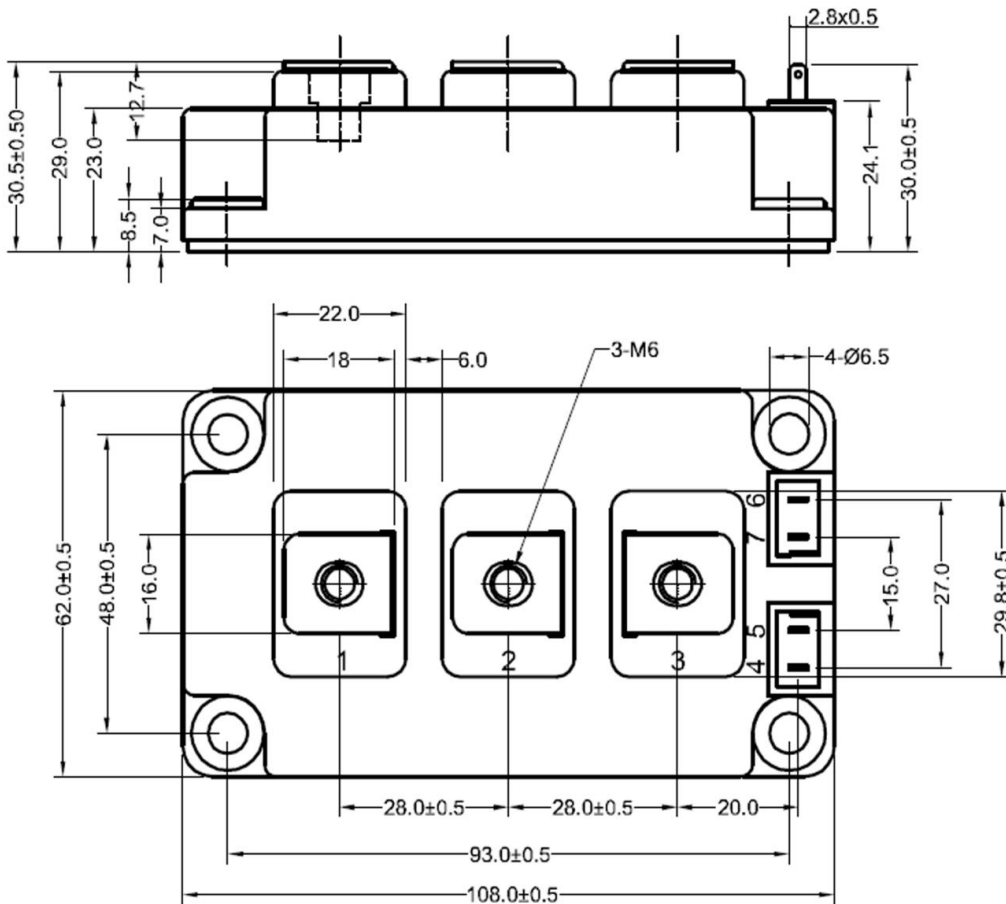


Figure 14. Package Outline